

Application/Control No. 10/621,461	Applicant(s)/Patent under Reexamination KIM ET AL.
Examiner	Art Unit
Duc T. Doan	2188

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	ORIGINAL		INTERNATIONAL CLASSIFICATION										
	CLASS	SUBCLASS			CI	AIMED		NON-CLA	NON-CLAIMED				
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Claims renumbered in the same order as presented by applicant						☐ CPA			☐ T.D.		☐ R.1.47								
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